

Application/Control No.	T

Applicant(s)/Patent under Reexamination

09/629,318 Examiner

Thien D. Tran

AH SUE, JOHN D.
Art Unit

2665

SEARCHED					
Class	Subclass	Date	Examiner		
370	236.1	6/13/2005	тт		
	236.2	6/13/2005	TT		
	395.1	6/13/2005	TT		
	397	6/13/2005	тт		
*	398	6/13/2005	тт		
	395.3	6/13/2005	тт		
	493	6/13/2005	тт		
	494	6/13/2005	TT		
	495	6/13/2005	тт		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
370	493	6/13/2005	тт		
	395.3	6/13/2005	тт		
	236.2	6/13/2005	π		

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
East	6/13/2005	π
East	6/13/2005	т
East	6/13/2005	тт
East	6/13/2005	π
	6/13/2005	π